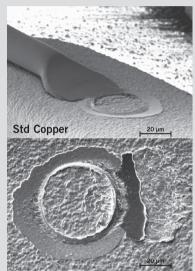
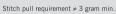
Heraeus

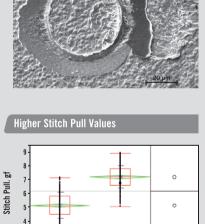
MaxSoft

Copper Wire for High Pin Count and Fine Pitch Applications









MaxSoft

Tukey-Kramer 0.05

MaxSoft Benefits

- Excellent 1st and 2nd bond performance
- Reduced pad metal splash
- Wider 2nd bond process window

Features

- Soft wire and FAB allow bonding on sensitive pad structures
- Excellent conductivity with less heat generation
- Available in diameters ranging from 0.6 – 1.3 mil

Bonding Conditions: Wire diameter: MaxSoft / Standard Copper at 1 mil · Device: K&S PBGA 2 X 2 test die · Capillary: Cupra C8-FC1011-R34 (T=4.0 mils) · Bonder: K&S 8028 PPS Bonding temperature: 175°C

Recommended Technical Data of MoxSoff									
Diameter	Microns	15	18	20	23	25	28	30	33
	Mils	0.6	0.7	0.8	0.9	1.0	1.1	1.2	1.3
Recommended Specs for Ball Bonding									
Elongation (%)		7 - 15	7 – 15	7 – 15	8 – 16	8 - 16	8 - 16	8 – 16	8 - 16
Breaking Load (g)		3 - 6	3 – 8	4 – 10	5 – 11	6 - 12	8 - 15	10 – 18	14 - 21

Std Copper

Wire Type

For other diameters, please contact Heraeus Bonding Wires sales representative.

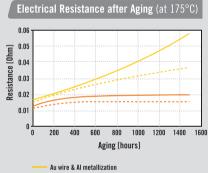
MoxSoff Characteristics for 1 mil diameter	
Physical Properties	
Density	8.92 g/cm ³
Melting Point	1083 °C
Thermal Conductivity	401 W/m.K
Specific Heat Capacity @ 25 °C	385 J/kg.K
Coeff. of Thermal Expansion	16.5 μm/m °C, (20 – 100 °C)
Electrical Resistivity	1.69 μ Ω /cm
FAB Hardness (120 mA EFO)	85 – 95 HV (0.01 N/5 s)
Elastic Modulus	$80\sim 90$ GPa
Chemical Composition	
Copper	99.99% (min)

Other Guidelines

Reduced Pad Metal Splash

Floor Life	7 days
Shelf Life Time	6 month
Recommended Shielding Gas	Forming Gas (95%N2, 5%H2)
Bonding Temperature (Leadframe)	200 – 240 °C
Bonding Temperature (Laminate)	165 − 175 °C

Resistance vs Wire Diameter 3.00 Au 2N – Au 4N 2.50 Cu E 2.00 E 1.50 1.00 0.50 $0.00\frac{1}{0}$ 10 20 30 40 Wire diameter [µm]

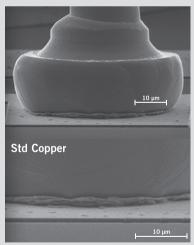


Au wire & Al/Cu/Si metallization Cu wire & AL metallization ---- Cu wire & Al/Cu/Si metallization

Copper Wire Products

High

10 µm MaxSoft



Application requirement MaxSoft MaxSoftLD iCu DHF 0.8 1.3 Wire diameter (mils)

Bond pad: Al-1% Si-0.5Cu 10,000 - other conditions refer to front page

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3.0

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